

Material No.: 9466-03 Batch No.: 23L1861090

Manufactured Date: 2023-12-13 Retest Date: 2028-12-11

Revision No.: 0

## Certificate of Analysis

Test	Specification	Result
Assay (C6H5CH3) (by GC)	≥ 99.5 %	99.9 %
Color (APHA)	≤ 10	< 5
Acidity (µeq/g)	≤ 0.2	< 0.1
Residue after Evaporation	≤ 2.0 ppm	< 1.0 ppm
Water (by KF, coulometric)	≤ 0.03 %	0.03 %
Substances Darkened by H <sub>2</sub> SO <sub>4</sub>	Passes Test	Passes Test
Sulfur Compounds (as S)	≤ 0.003 %	< 0.003 %
Chloride (Cl)	≤ 2 ppm	< 2 ppm
Phosphate (PO <sub>4</sub> )	≤ 0.5 ppm	< 0.5 ppm
Trace Impurities - Aluminum (Al)	≤ 20 ppb	< 5 ppb
Arsenic and Antimony (as As)	≤ 10.0 ppb	< 10.0 ppb
Trace Impurities – Barium (Ba)	≤ 10.0 ppb	< 1.0 ppb
Trace Impurities - Boron (B)	$\leq 20.0 \text{ ppb}$	< 5.0 ppb
Trace Impurities - Cadmium (Cd)	$\leq 20.0 \text{ ppb}$	< 1.0 ppb
Trace Impurities - Calcium (Ca)	≤ 100.0 ppb	1.3 ppb
Trace Impurities - Chromium (Cr)	≤ 10.0 ppb	< 1.0 ppb
Trace Impurities - Cobalt (Co)	≤ 20 ppb	< 1 ppb
Trace Impurities - Copper (Cu)	$\leq 20.0 \text{ ppb}$	< 1.0 ppb
Trace Impurities - Gallium (Ga)	≤ 50 ppb	< 1 ppb
Trace Impurities - Germanium (Ge)	≤ 50.0 ppb	< 10.0 ppb
Trace Impurities - Gold (Au)	≤ 20 ppb	< 5 ppb
Heavy Metals (as Pb)	≤ 500.0 ppb	< 500.0 ppb
Trace Impurities – Iron (Fe)	$\leq$ 20.0 ppb	< 1.0 ppb
Trace Impurities – Lithium (Li)	$\leq 20.0 ppb$	< 1.0 ppb
Trace Impurities – Magnesium (Mg)	≤ 10.0 ppb	< 1.0 ppb
Trace Impurities – Manganese (Mn)	$\leq$ 10.0 ppb	< 1.0 ppb
Trace Impurities – Nickel (Ni)	$\leq$ 20.0 ppb	< 5.0 ppb
Trace Impurities – Potassium (K)	≤ 50 ppb	< 10 ppb

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Toluene CMOS



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Test	Specification	Result
Trace Impurities - Silicon (Si)	≤ 100.0 ppb	< 10.0 ppb
Trace Impurities - Silver (Ag)	≤ 20.0 ppb	< 1.0 ppb
Trace Impurities – Sodium (Na)	≤ 100.0 ppb	< 5.0 ppb
Trace Impurities - Strontium (Sr)	≤ 10.0 ppb	< 1.0 ppb
Trace Impurities - Tin (Sn)	≤ 30.0 ppb	< 10.0 ppb
Trace Impurities - Zinc (Zn)	≤ 20.0 ppb	< 1.0 ppb
Particle Count – 1.0 µm and greater	≤ 10 par/ml	< 1 par/ml

For Microelectronic Use

Country of Origin: USA Packaging Site: Paris Mfg Ctr & DC



Sr. Manager, Quality Assurance